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| Notice of References Cited | Application/Control No. 10/587,183 | | Applicant(s)/Patent Under Reexamination NODA ET AL. | |
| | Examiner DUC M. NGUYEN | | Art Unit 2618 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|------------------------|----------------|
| * | A | US-6,961,019 | 11-2005 | McConnell et al. | 342/357.1 |
| * | B | US-6,771,931 | 08-2004 | Waltho, Alan E. | 455/24 |
| * | C | US-7,177,663 | 02-2007 | Axness et al. | 455/552.1 |
| * | D | US-7,058,368 | 06-2006 | Nicholls et al. | 455/114.2 |
| * | E | US-5,860,057 | 01-1999 | Ishida et al. | 455/12.1 |
| * | F | US-5,691,978 | 11-1997 | Kenworthy, Gary Robert | 370/278 |
| * | G | US-6,996,164 | 02-2006 | Blount et al. | 375/219 |
| * | H | US-6,704,349 | 03-2004 | Masenten, Wesley K. | 375/219 |
| * | I | US-6,526,264 | 02-2003 | Sugar et al. | 455/84 |
| * | J | US-5,771,440 | 06-1998 | Sukhu et al. | 455/63.1 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

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